Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/940,242	VAN DE VANTER ET AL.	
Examiner	Art Unit	
Todd Ingberg	2193	

	SEARCHED					
Class	Subclass	Date	Examiner			
דור	112	6/22/02	TF			
	111					
	113					
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715	542	*				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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